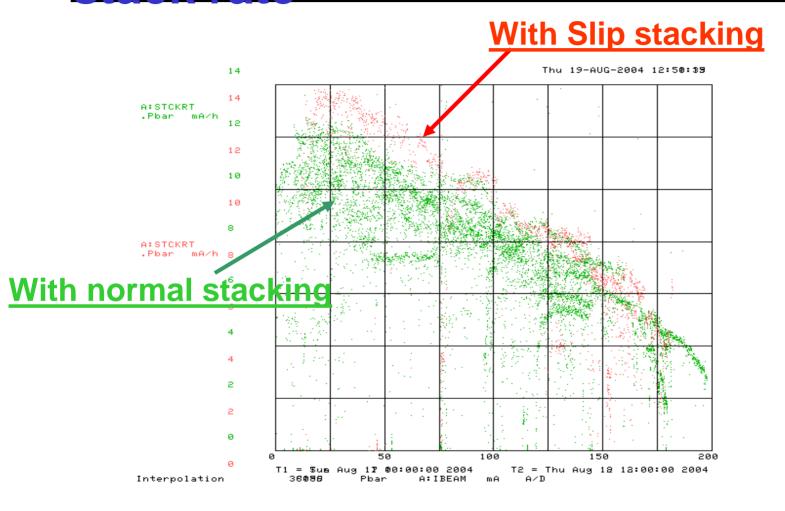


Slip stacking Operation and Future Plan

Kiyomi Seiya Fermilab March 29, 2005

Effect of slip stacking on stack rate





Outline



Status of slip stacking operation

- Issues
 - Emittance from Booster
 - Balancer circuit for bunch rotation
- Future plans

Our goal for pbar stacking



Intensity: 8E12 [ppp] (particle per pulse)

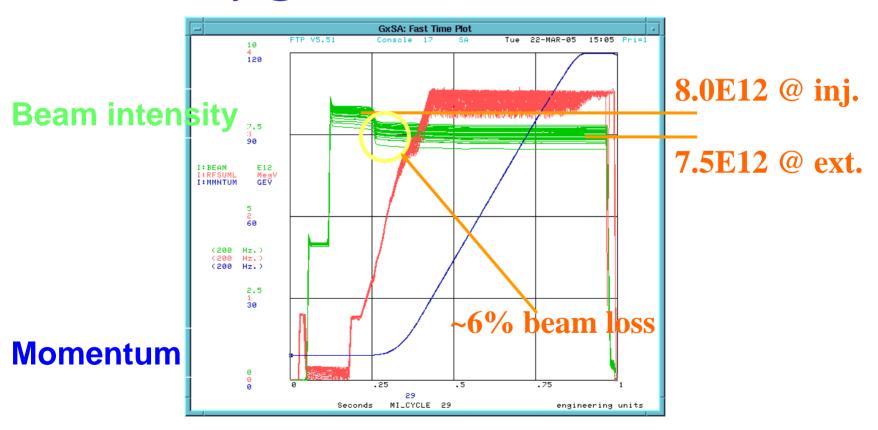
Bunch length at extraction: < 1.5 nsec

• Time of slip stacking process: 200msec (<3 Booster cycles)

Intensity on stacking cycle



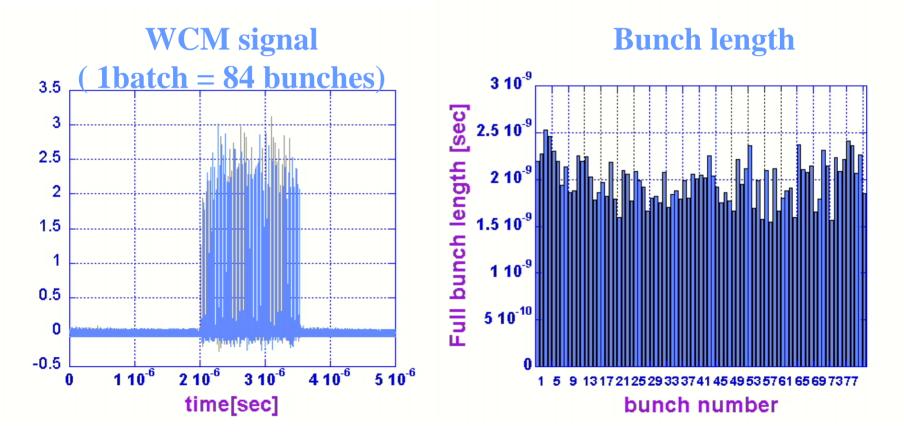
Intensity @ ext.: 7.5E12



WCM signal and bunch length at extraction



Bunch length @ ext.: ~1.8 nsec



Intensity on Pbar target

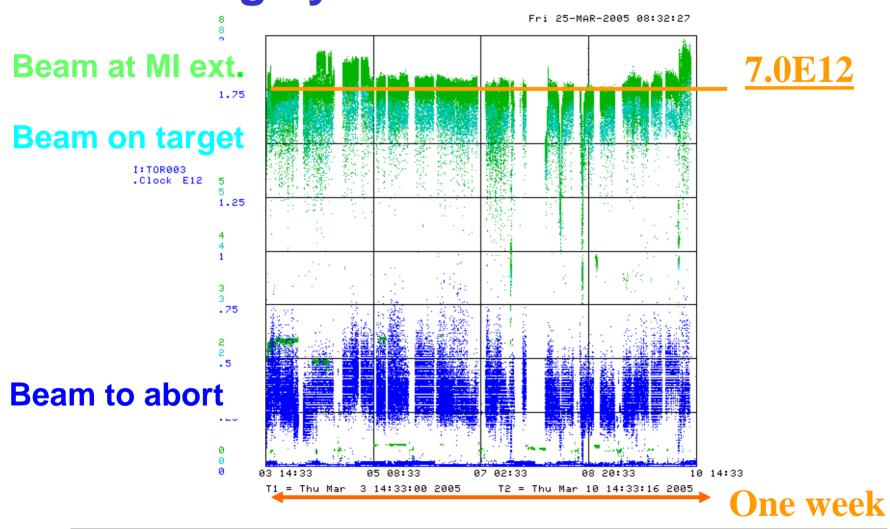


Intensity on Pbar target: 7.0E12



Operation condition on stacking cycle





Status



- Intensity: 7.5E12 (@ MI ext.)
 - Intensity @ inj.: 8.0E12
 - Intensity on Pbar target: 7.0E12
 - Intensity to abort line: 0.5E12
- Bunch length @ ext.: 1.8 nsec

Time of slip stacking process: 184 msec

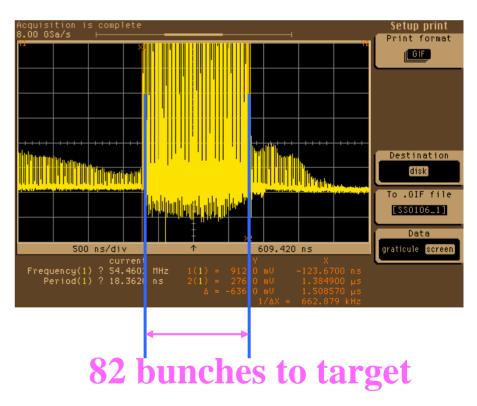
Wall current monitor at extraction



300mV/div

Acquisition is complete 8.00 GSa/s Print format GIF Destination disk To .GIF file [SS0106_2] Data raticule screen Frequency(1) 13.30906 HHz 1(1) = 912 mU -123.6700 ns Period(1) 75.1368 ns 2(1) = 276 mU 1.384900 µs A = -636 mU 1.508570 µs 1/AX = 662.879 kHz

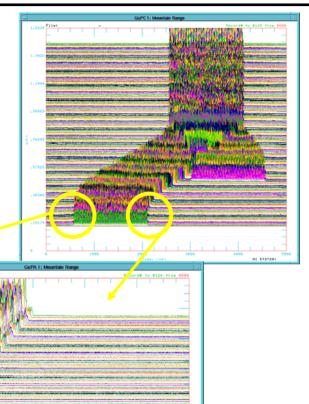
10mV/div

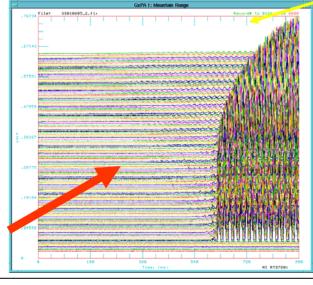


WCM signal at injection



 Beam starts leaking at injection

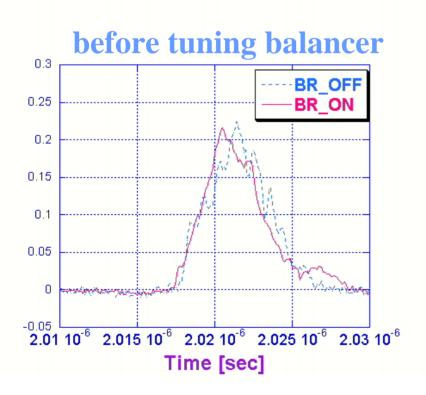


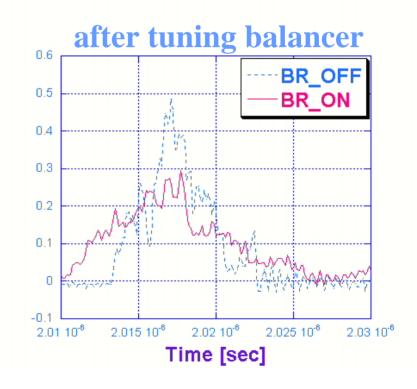


WCM signal at injection with and w/o bunch rotation



Tuned up balancer in Booster for bunch rotation

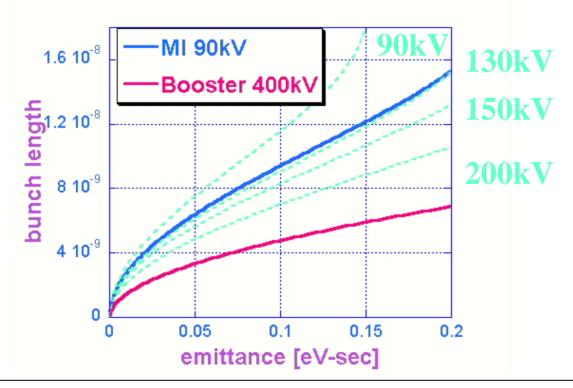




Bunch rotation at Booster extraction

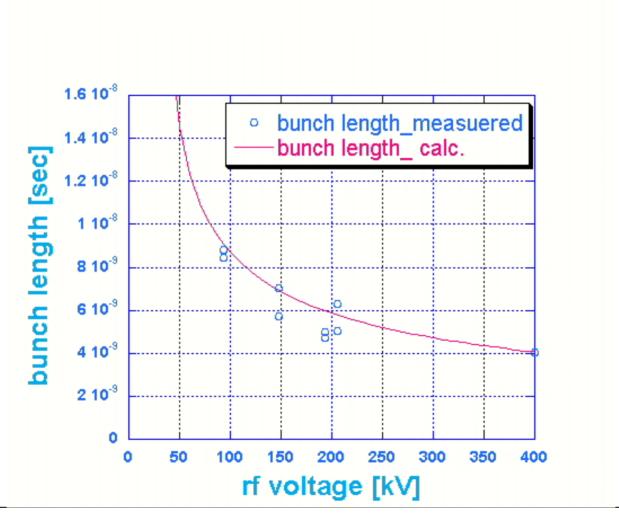


Vrf @ Booster ext.: 400kV ←→ Vrf @MI inj.: 90kV



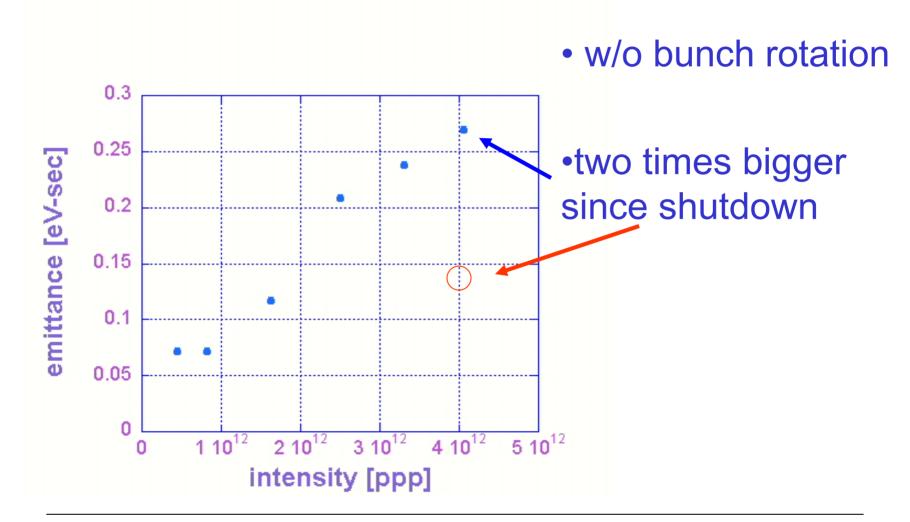
Bunch rotation study with low intensity





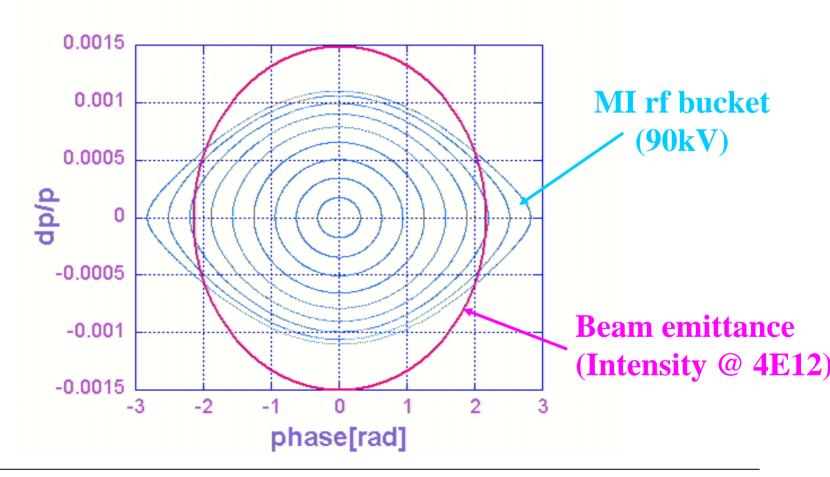
Beam emittance vs Intensity from Booster





Beam emittance on MI rf bucket





Future plan



- To fix un-captured beam at injection
 - Emittance from Booster
 - Balancer circuit for bunch rotation
- Increase intensity to 8E12 on TARGET

- Slip stacking for multi-batch operation
 - Simulation
 - Beam study

Double intensity on Numi multi-batch



